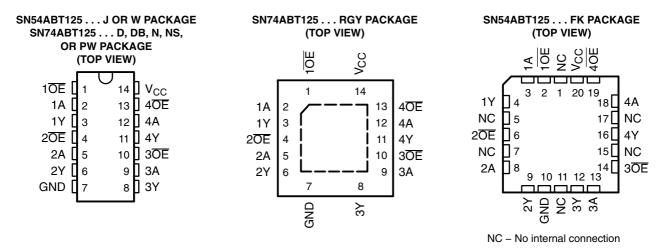
#### SN54ABT125, SN74ABT125 QUADRUPLE BUS BUFFER GATES WITH 3-STATE OUTPUTS

SCBS182I - FEBRUARY 1997 - REVISED NOVEMBER 2002

- Typical V<sub>OLP</sub> (Output Ground Bounce)
  <1 V at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C
- High-Drive Outputs (–32-mA I<sub>OH</sub>, 64-mA I<sub>OL</sub>)
- I<sub>off</sub> and Power-Up 3-State Support Hot Insertion
- Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17
- ESD Protection Exceeds JESD 22
  2000-V Human-Body Model (A114-A)
  200 V Machine Model (A115 A)
  - 200-V Machine Model (A115-A)



#### description/ordering information

The 'ABT125 quadruple bus buffer gates feature independent line drivers with 3-state outputs. Each output is disabled when the associated output-enable ( $\overline{OE}$ ) input is high.

These devices are fully specified for hot-insertion applications using I<sub>off</sub> and power-up 3-state. The I<sub>off</sub> circuitry disables the outputs, preventing damaging current backflow through the devices when they are powered down. The power-up 3-state circuitry places the outputs in the high-impedance state during power up and power down, which prevents driver conflict.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to V<sub>CC</sub> through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

T <sub>A</sub>	PACK	AGE <sup>†</sup>	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	PDIP – N	Tube	SN74ABT125N	SN74ABT125N
	QFN – RGY	Tape and reel	SN74ABT125RGYR	AB125
		Tube	SN74ABT125D	
–40°C to 85°C	SOIC – D	Tape and reel	SN74ABT125DR	ABT125
	SOP – NS	Tape and reel	SN74ABT125NSR	ABT125
	SSOP – DB	Tape and reel	SN74ABT125DBR	AB125
	TSSOP – PW	Tape and reel	SN74ABT125PWR	AB125
	CDIP – J	Tube	SNJ54ABT125J	SNJ54ABT125J
–55°C to 125°C	CFP – W	Tube	SNJ54ABT125W	SNJ54ABT125W
	LCCC – FK	Tube	SNJ54ABT125FK	SNJ54ABT125FK

#### **ORDERING INFORMATION**

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



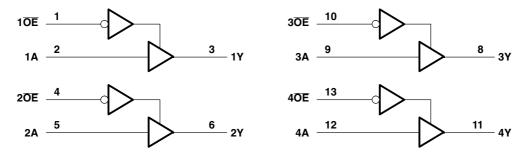
 $Copyright @ 2002, \ Texas \ Instruments \ Incorporated \\ On products \ compliant to \ MIL-PRF-38535, all parameters are tested \\ unless \ otherwise \ noted. \ On \ all \ other \ products, \ production \\ processing \ does \ not \ necessarily \ include \ testing \ of \ all \ parameters. \$ 

#### SN54ABT125, SN74ABT125 QUADRUPLE BUS BUFFER GATES WITH 3-STATE OUTPUTS

SCBS182I - FEBRUARY 1997 - REVISED NOVEMBER 2002

FUNCTION TABLE (each buffer)									
INP	UTS	OUTPUT							
OE	Α	Y							
L	Н	Н							
L	L	L							
Н	Х	Z							

#### logic diagram (positive logic)



Pin numbers shown are for the D, DB, J, N, NS, PW, RGY, and W packages.

#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range, V <sub>CC</sub> Input voltage range, V <sub>I</sub> (see Note 1)	
Voltage range applied to any output in the high or power-off state, Vo	
Current into any output in the low state, Io: SN54ABT125	
SN74ABT125	
Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0)	
Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0)	
Package thermal impedance, θ <sub>JA</sub> (see Note 2): D package	
(see Note 2): DB package	
(see Note 2): N package	80°C/W
(see Note 2): NS package	
(see Note 2): PW package	
(see Note 3): RGY package	47°C/W
Storage temperature range, T <sub>stg</sub>	

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51-7.

3. The package thermal impedance is calculated in accordance with JESD 51-5.



# SN54ABT125, SN74ABT125 QUADRUPLE BUS BUFFER GATES WITH 3-STATE OUTPUTS SCBS182I – FEBRUARY 1997 – REVISED NOVEMBER 2002

### recommended operating conditions (see Note 4)

		SN54A	BT125	SN74A		
		MIN	MAX	MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage	4.5	5.5	4.5	5.5	V
V <sub>IH</sub>	High-level input voltage	2		2		V
V <sub>IL</sub>	Low-level input voltage		0.8		0.8	V
VI	Input voltage	0	$V_{CC}$	0	$V_{CC}$	V
I <sub>OH</sub>	High-level output current		-24		-32	mA
I <sub>OL</sub>	Low-level output current		48		64	mA
$\Delta t / \Delta v$	Input transition rise or fall rate		10		10	ns/V
$\Delta t / \Delta V_{CC}$	Power-up ramp rate	200		200		μs/V
T <sub>A</sub>	Operating free-air temperature	-55	125	-40	85	°C

NOTE 4: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



#### SN54ABT125, SN74ABT125 QUADRUPLE BUS BUFFER GATES WITH 3-STATE OUTPUTS

SCBS182I - FEBRUARY 1997 - REVISED NOVEMBER 2002

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

				٦	Γ <sub>A</sub> = 25°C	;	SN54A	BT125	SN74A	BT125		
PARA	METER	TEST CO	NDITIONS	MIN	TYP <sup>†</sup>	MAX	MIN	MAX	MIN	MAX	UNIT	
V <sub>IK</sub>		V <sub>CC</sub> = 4.5 V,	I <sub>I</sub> = -18 mA			-1.2		-1.2		-1.2	V	
		V <sub>CC</sub> = 4.5 V,	I <sub>OH</sub> = -3 mA	2.5			2.5		2.5			
V		$V_{CC} = 5 V,$	I <sub>OH</sub> = -3 mA	3			3		3		V	
V <sub>OH</sub>	-		I <sub>OH</sub> = -24 mA	2			2				V	
		V <sub>CC</sub> = 4.5 V	I <sub>OH</sub> = -32 mA	2*					2			
		N 45.1	I <sub>OL</sub> = 48 mA			0.55		0.55			v	
V <sub>OL</sub>		V <sub>CC</sub> = 4.5 V	I <sub>OL</sub> = 64 mA			0.55*				0.55	v	
V <sub>hys</sub>					100						mV	
lj		$V_{CC} = 0$ to 5.5 V,	$V_I = V_{CC}$ or GND			±1		±1		±1	μA	
I <sub>OZPU</sub>		$V_{CC} = 0$ to 2.1 V, $V_{O} = 0$	$V_{O} = 0.5 V \text{ to } 2.7 V, \overline{OE} = X \pm 50 \pm 50$					±50	μA			
I <sub>OZPD</sub>		$V_{CC}$ = 2.1 V to 0, $V_{O}$ =	= 0.5 V to 2.7 V, $\overline{OE}$ = X ±50				±50		±50	μA		
I <sub>OZH</sub>		$V_{CC} = 2.1 \text{ V to } 5.5 \text{ V},$	$V_{O} = 2.7 \text{ V}, \ \overline{OE} \ge 2 \text{ V}$			10		10		10 μA		
I <sub>OZL</sub>		$V_{CC} = 2.1 \text{ V to } 5.5 \text{ V},$	$V_{O} = 0.5 \text{ V}, \ \overline{OE} \ge 2 \text{ V}$			-10		-10		-10	μA	
I <sub>off</sub>		V <sub>CC</sub> = 0,	$V_{I} \text{ or } V_{O} \leq 4.5 \text{ V}$			±100				±100	μA	
I <sub>CEX</sub>		V <sub>CC</sub> = 5.5 V, V <sub>O</sub> = 5.5 V	Outputs high			50		50		50	μA	
lo‡		V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 2.5 V	-50	-100	-200 <sup>§</sup>	-50	-200§	-50	-200§	mA	
		V <sub>CC</sub> = 5.5 V,	Outputs high		1	250		250		250	μA	
I <sub>CC</sub>		$l_0 = 0,$	Outputs low		24	30		30		30	mA	
		$V_{I} = V_{CC}$ or GND	Outputs disabled		0.5	250		250		250	μA	
	Data	V <sub>CC</sub> = 5.5 V, One input at 3.4 V,	Outputs enabled			1.5		1.5		1.5		
$\Delta I_{CC}^{\P}$	inputs	Other inputs at $V_{CC}$ or GND	Outputs disabled			0.05		0.05		0.05	mA	
	Control inputs	$V_{CC}$ = 5.5 V, One input Other inputs at $V_{CC}$ or 0	5.5 V, One input at 3.4 V, nputs at V <sub>CC</sub> or GND			1.5		1.5		1.5		
Ci		V <sub>I</sub> = 2.5 V or 0.5 V			3						pF	
Co		V <sub>O</sub> = 2.5 V or 0.5 V			7						pF	

\* On products compliant to MIL-PRF-38535, this parameter does not apply.

<sup>†</sup> All typical values are at  $V_{CC} = 5$  V.

<sup>‡</sup> Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

§ This limit may vary among suppliers.

<sup>¶</sup> This is the increase in supply current for each input that is at the specified TTL voltage level, rather than V<sub>CC</sub> or GND.



### SN54ABT125, SN74ABT125 **QUADRUPLE BUS BUFFER GATES** WITH 3-STATE OUTPUTS SCBS182I – FEBRUARY 1997 – REVISED NOVEMBER 2002

# switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

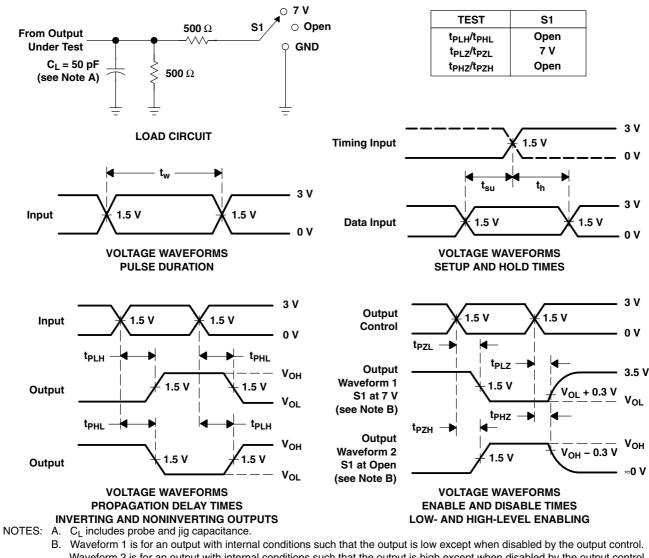
PARAMETER	FROM	TO	V <sub>CC</sub> = 5 V, T <sub>A</sub> = 25°C			SN54A	BT125	SN74A	UNIT	
	(INPUT)	(OUTPUT)	MIN	ТҮР	MAX	MIN	MAX	MIN	MAX	
t <sub>PLH</sub> †	•	V	1	3.2	4.6	1	6	1	4.9	
t <sub>PHL</sub> †	A	Ŷ	1	2.5	4.6	1	6.2	1	4.9	ns
t <sub>PZH</sub> †	25	Y	1	3.6	5	1	6	1	5.9	
t <sub>PZL</sub> †	ŌĒ		1	2.5	6.2	1	7.5	1	6.8	ns
t <sub>PHZ</sub>		V	1	3.8	5.4	1	6.3	1	6.2	
t <sub>PLZ</sub> †	ŌĒ	Y	1	3.3	5.3	1	6.5	1	6.2	ns

<sup>†</sup> This limit may vary among suppliers.



#### SN54ABT125, SN74ABT125 **QUADRUPLE BUS BUFFER GATES** WITH 3-STATE OUTPUTS

SCBS182I - FEBRUARY 1997 - REVISED NOVEMBER 2002



#### PARAMETER MEASUREMENT INFORMATION

Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control. C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>0</sub> = 50  $\Omega$ , t<sub>f</sub>  $\leq$  2.5 ns, t<sub>f</sub>  $\leq$  2.5 ns.

D. The outputs are measured one at a time with one transition per measurement.

E. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms





#### PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
5962-9676801Q2A	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 9676801Q2A SNJ54ABT 125FK	Samples
5962-9676801QCA	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9676801QC A SNJ54ABT125J	Samples
5962-9676801QDA	ACTIVE	CFP	W	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9676801QD A SNJ54ABT125W	Samples
SN74ABT125D	ACTIVE	SOIC	D	14	50	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABT125	Samples
SN74ABT125DBR	ACTIVE	SSOP	DB	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AB125	Samples
SN74ABT125DE4	ACTIVE	SOIC	D	14	50	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABT125	Samples
SN74ABT125DG4	ACTIVE	SOIC	D	14	50	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABT125	Samples
SN74ABT125DR	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABT125	Samples
SN74ABT125DRE4	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABT125	Samples
SN74ABT125DRG4	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABT125	Samples
SN74ABT125N	ACTIVE	PDIP	N	14	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 85	SN74ABT125N	Samples
SN74ABT125NSR	ACTIVE	SOP	NS	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABT125	Samples
SN74ABT125PW	ACTIVE	TSSOP	PW	14	90	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AB125	Samples
SN74ABT125PWG4	ACTIVE	TSSOP	PW	14	90	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AB125	Samples
SN74ABT125PWR	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AB125	Samples
SN74ABT125PWRE4	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AB125	Samples
SN74ABT125PWRG4	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AB125	Samples

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
SN74ABT125RGYR	ACTIVE	VQFN	RGY	14	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	AB125	Samples
SNJ54ABT125FK	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 9676801Q2A SNJ54ABT 125FK	Samples
SNJ54ABT125J	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9676801QC A SNJ54ABT125J	Samples
SNJ54ABT125W	ACTIVE	CFP	W	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9676801QD A SNJ54ABT125W	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <= 1000ppm threshold. Antimony trioxide based flame retardants must also meet the <= 1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.



### PACKAGE OPTION ADDENDUM

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

#### OTHER QUALIFIED VERSIONS OF SN54ABT125, SN74ABT125 :

- Catalog : SN74ABT125
- Military : SN54ABT125

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

www.ti.com

Texas

STRUMENTS

#### TAPE AND REEL INFORMATION





#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



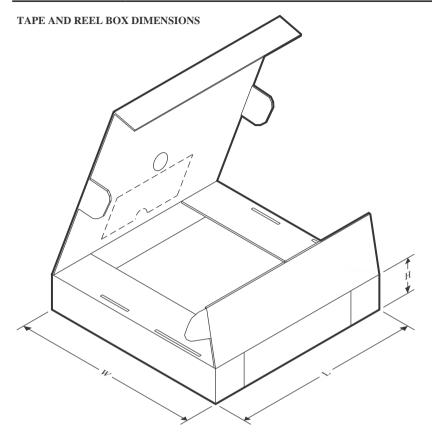
All dimensions are nominal	- <u>r</u>		<u> </u>									
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74ABT125DBR	SSOP	DB	14	2000	330.0	16.4	8.35	6.6	2.4	12.0	16.0	Q1
SN74ABT125DR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74ABT125NSR	SOP	NS	14	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
SN74ABT125PWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74ABT125RGYR	VQFN	RGY	14	3000	330.0	12.4	3.75	3.75	1.15	8.0	12.0	Q1



www.ti.com

### PACKAGE MATERIALS INFORMATION

7-Dec-2024



*All	dimensions	are	nominal	
------	------------	-----	---------	--

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74ABT125DBR	SSOP	DB	14	2000	356.0	356.0	35.0
SN74ABT125DR	SOIC	D	14	2500	353.0	353.0	32.0
SN74ABT125NSR	SOP	NS	14	2000	356.0	356.0	35.0
SN74ABT125PWR	TSSOP	PW	14	2000	356.0	356.0	35.0
SN74ABT125RGYR	VQFN	RGY	14	3000	356.0	356.0	35.0

#### TEXAS INSTRUMENTS

www.ti.com

7-Dec-2024

#### TUBE



#### - B - Alignment groove width

*All dimensions are nominal
-----------------------------

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	Τ (μm)	B (mm)
5962-9676801Q2A	FK	LCCC	20	55	506.98	12.06	2030	NA
5962-9676801QDA	W	CFP	14	25	506.98	26.16	6220	NA
SN74ABT125D	D	SOIC	14	50	507	8	3940	4.32
SN74ABT125D	D	SOIC	14	50	506.6	8	3940	4.32
SN74ABT125DE4	D	SOIC	14	50	506.6	8	3940	4.32
SN74ABT125DE4	D	SOIC	14	50	507	8	3940	4.32
SN74ABT125DG4	D	SOIC	14	50	506.6	8	3940	4.32
SN74ABT125DG4	D	SOIC	14	50	507	8	3940	4.32
SN74ABT125N	N	PDIP	14	25	506	13.97	11230	4.32
SN74ABT125N	N	PDIP	14	25	506	13.97	11230	4.32
SN74ABT125PW	PW	TSSOP	14	90	530	10.2	3600	3.5
SN74ABT125PWG4	PW	TSSOP	14	90	530	10.2	3600	3.5
SNJ54ABT125FK	FK	LCCC	20	55	506.98	12.06	2030	NA
SNJ54ABT125W	W	CFP	14	25	506.98	26.16	6220	NA

# **D0014A**



### **PACKAGE OUTLINE**

#### SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm, per side.
- 5. Reference JEDEC registration MS-012, variation AB.



# D0014A

# **EXAMPLE BOARD LAYOUT**

#### SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



### D0014A

# **EXAMPLE STENCIL DESIGN**

#### SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



#### MECHANICAL DATA

#### PLASTIC SMALL-OUTLINE PACKAGE

#### 0,51 0,35 ⊕0,25⊛ 1,27 8 14 0,15 NOM 5,60 8,20 5,00 7,40 $\bigcirc$ Gage Plane ₽ 0,25 7 1 1,05 0,55 0°-10° Δ 0,15 0,05 Seating Plane — 2,00 MAX 0,10PINS \*\* 14 16 20 24 DIM 10,50 10,50 12,90 15,30 A MAX A MIN 9,90 9,90 12,30 14,70 4040062/C 03/03

NOTES: A. All linear dimensions are in millimeters.

NS (R-PDSO-G\*\*)

**14-PINS SHOWN** 

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



W (R-GDFP-F14)

CERAMIC DUAL FLATPACK



- A. All linear dimensions are in inches (millimeters).
  - B. This drawing is subject to change without notice.
  - C. This package can be hermetically sealed with a ceramic lid using glass frit.
  - D. Index point is provided on cap for terminal identification only.
  - E. Falls within MIL STD 1835 GDFP1-F14



# **DB0014A**



### **PACKAGE OUTLINE**

#### SSOP - 2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not

- exceed 0.15 mm per side. 4. Reference JEDEC registration MO-150.



### DB0014A

# **EXAMPLE BOARD LAYOUT**

#### SSOP - 2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

5. Publication IPC-7351 may have alternate designs.

6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



### DB0014A

# **EXAMPLE STENCIL DESIGN**

#### SSOP - 2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

8. Board assembly site may have different recommendations for stencil design.



### FK 20

#### 8.89 x 8.89, 1.27 mm pitch

### **GENERIC PACKAGE VIEW**

#### LCCC - 2.03 mm max height

LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





### **GENERIC PACKAGE VIEW**

### CDIP - 5.08 mm max height

CERAMIC DUAL IN LINE PACKAGE



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



# J0014A



### **PACKAGE OUTLINE**

#### CDIP - 5.08 mm max height

CERAMIC DUAL IN LINE PACKAGE



NOTES:

- 1. All controlling linear dimensions are in inches. Dimensions in brackets are in millimeters. Any dimension in brackets or parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This package is hermitically sealed with a ceramic lid using glass frit.
- Index point is provided on cap for terminal identification only and on press ceramic glass frit seal only.
  Falls within MIL-STD-1835 and GDIP1-T14.



### J0014A

### **EXAMPLE BOARD LAYOUT**

#### CDIP - 5.08 mm max height

CERAMIC DUAL IN LINE PACKAGE





### N (R-PDIP-T\*\*)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- $\triangle$  The 20 pin end lead shoulder width is a vendor option, either half or full width.



# **PW0014A**



### **PACKAGE OUTLINE**

### TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



### PW0014A

# **EXAMPLE BOARD LAYOUT**

#### TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



### PW0014A

## **EXAMPLE STENCIL DESIGN**

#### TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

9. Board assembly site may have different recommendations for stencil design.



<sup>8.</sup> Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

### **RGY 14**

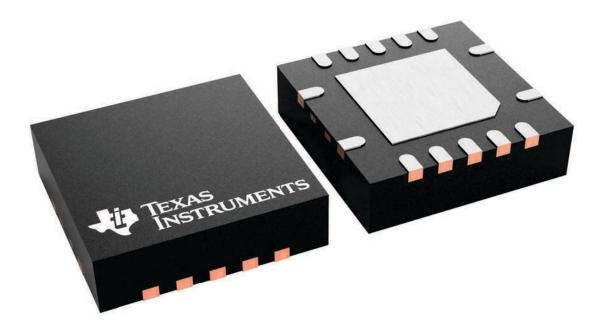
#### 3.5 x 3.5, 0.5 mm pitch

### **GENERIC PACKAGE VIEW**

#### VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





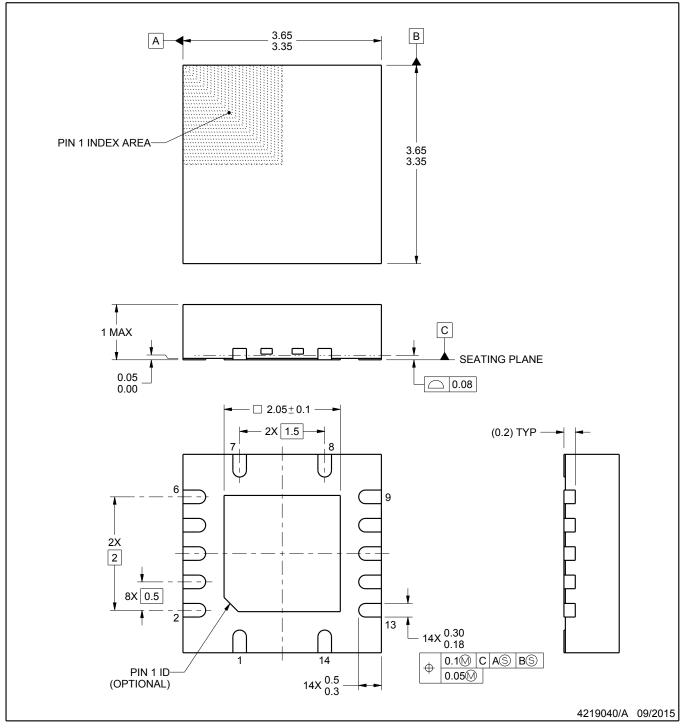
# **RGY0014A**



### **PACKAGE OUTLINE**

#### VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- This drawing is subject to change without notice.
  The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

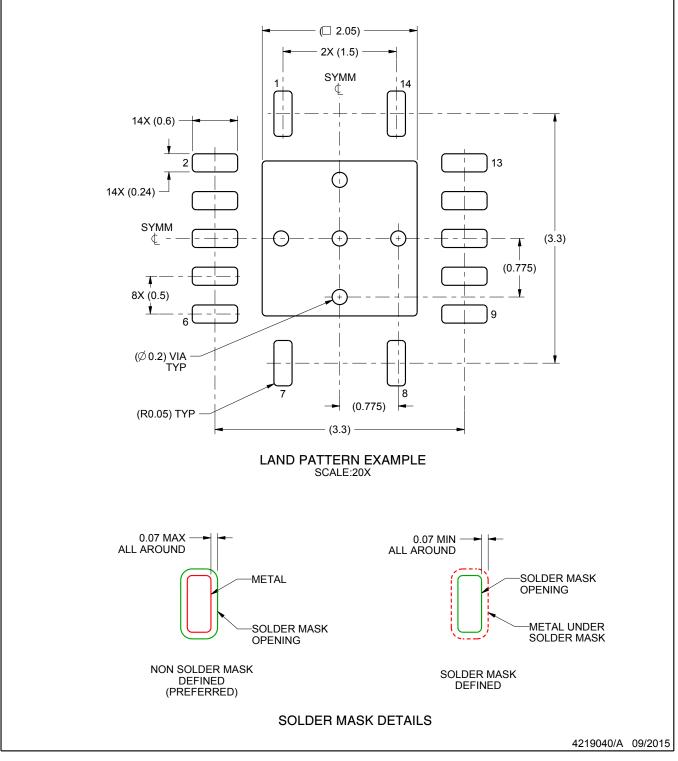


# **RGY0014A**

# **EXAMPLE BOARD LAYOUT**

#### VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

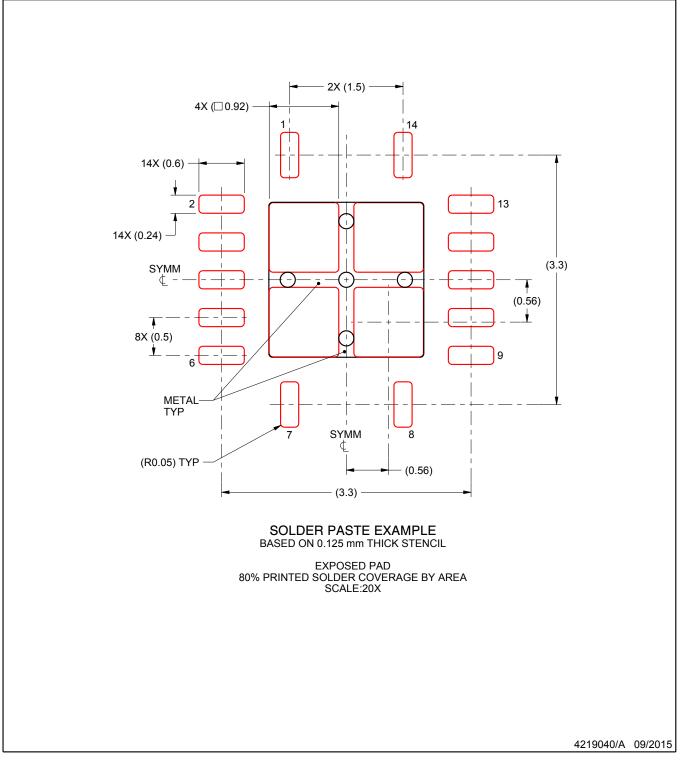


### **RGY0014A**

## **EXAMPLE STENCIL DESIGN**

#### VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



#### IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2025, Texas Instruments Incorporated